

Applicant  
Thomas Weide et al.LIST OF REFERENCES CITED BY APPLICANT  
(Use Several Sheets if Necessary)Filing Date  
Concurrently Herewith

Confirmation No.

## U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Name	Class	Subclass	Filing Date If Appropriate
SRH	AA	5,540,044	07/30/1996	Raasch	57	417	March 30, 1995
	AB						
	AC						
	AD						

## FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation Yes No
SRH	AE	DE 195 28 727 C2	08/02/1996	Germany (See attached Abstract)			X
SRH	AF	DE 199 63 087 A1	28/06/2001	Germany (See attached Abstract)			X
SRH	AF	DE 44 11 342 A1	05/10/1995	Germany (See attached Abstract)			X
SRH	AI	DE 39 42 454 A1	27/06/1991	Germany (See attached Abstract)			X
SRH	AI	DE-OS 25 52 955 A1	12/08/1976	Germany (See attached Abstract)			X
SRH	AJ	DE 24 21 415 A1	06/11/1975	Germany (See attached Abstract)			X
SRH	AK	DE 1 917 864 A1	11/12/1969	Germany			X
SRH	AL	DE 2 126 841	29/05/1971	Germany			X
	AM						
	AN						

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

SRH	AO	German Search Report
	AP	

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Date Considered

03/09/2005

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